

**Dual N-Channel Enhancement Mode Power MOSFET**

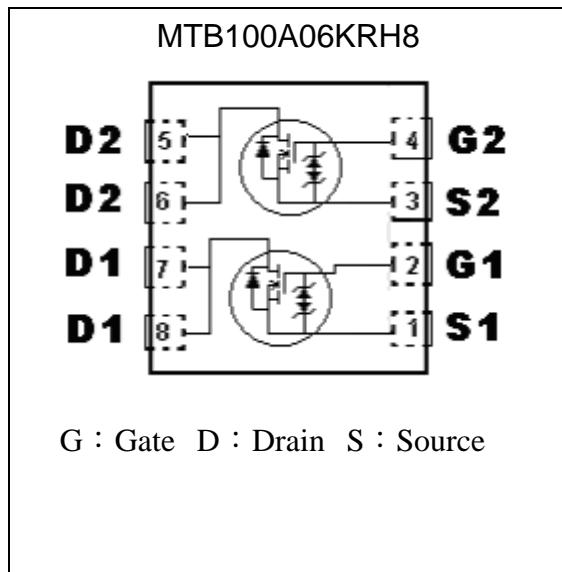
**MTB100A06KRH8**

<b>BV<sub>DSS</sub></b>	<b>60V</b>
<b>I<sub>D</sub>@V<sub>GS</sub>=10V, T<sub>C</sub>=25°C</b>	<b>11.3A</b>
<b>I<sub>D</sub>@V<sub>GS</sub>=10V, T<sub>C</sub>=100°C</b>	<b>7.1A</b>
<b>I<sub>D</sub>@V<sub>GS</sub>=10V, T<sub>A</sub>=25°C</b>	<b>3.2A</b>
<b>I<sub>D</sub>@V<sub>GS</sub>=10V, T<sub>A</sub>=70°C</b>	<b>2.6A</b>
<b>R<sub>DS(ON)</sub>@V<sub>GS</sub>=10V, I<sub>D</sub>=2.2A</b>	<b>82mΩ (typ)</b>
<b>R<sub>DS(ON)</sub>@V<sub>GS</sub>=4.5V, I<sub>D</sub>=1.3A</b>	<b>116mΩ (typ)</b>
<b>R<sub>DS(ON)</sub>@V<sub>GS</sub>=3.3V, I<sub>D</sub>=1A</b>	<b>183mΩ (typ)</b>

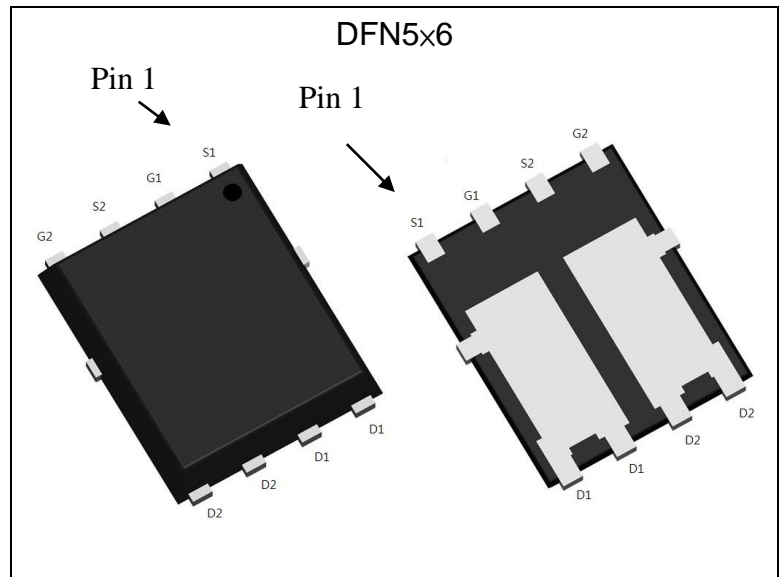
**Features**

- Low On Resistance
- Simple Drive Requirement
- Low Gate Charge
- Fast Switching Characteristic
- ESD protected gate
- Pb-free lead plating and Halogen-free package

**Equivalent Circuit**

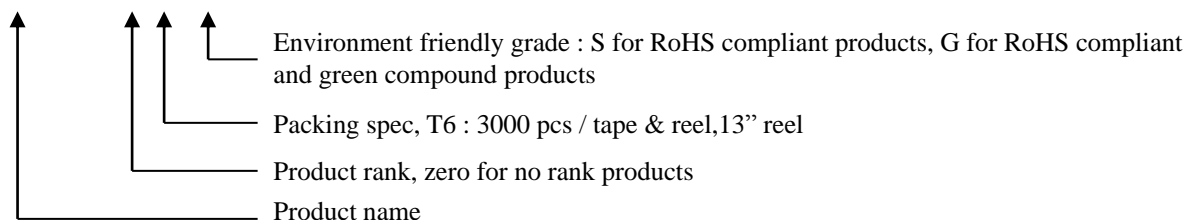


**Outline**



**Ordering Information**

Device	Package	Shipping
MTB100A06KRH8-0-T6-G	DFN 5 ×6 (Pb-free lead plating and halogen-free package)	3000 pcs / tape & reel





**Absolute Maximum Ratings** ( $T_C=25^{\circ}\text{C}$ , unless otherwise noted)

Parameter	Symbol	Limits	Unit
Drain-Source Voltage	$V_{DS}$	60	V
Gate-Source Voltage	$V_{GS}$	$\pm 20$	
Continuous Drain Current @ $T_C=25^{\circ}\text{C}$ , $V_{GS}=10\text{V}$ (Note 1)	$I_D$	11.3	A
Continuous Drain Current @ $T_C=100^{\circ}\text{C}$ , $V_{GS}=10\text{V}$ (Note 1)		7.1	
Continuous Drain Current @ $T_A=25^{\circ}\text{C}$ , $V_{GS}=10\text{V}$ (Note 2)	$I_{DSM}$	3.2	
Continuous Drain Current @ $T_A=70^{\circ}\text{C}$ , $V_{GS}=10\text{V}$ (Note 2)		2.6	
Pulsed Drain Current @ $V_{GS}=10\text{V}$ (Note 3)	$I_{DM}$	30	
Avalanche Current @ $L=100\mu\text{H}$ (Note 3)	$I_{AS}$	4	
Single Pulse Avalanche Energy @ $L=1\text{mH}$ , $I_D=3\text{A}$ , $V_{DD}=10\text{V}$ (Note 5)	$E_{AS}$	4.5	mJ
Repetitive Avalanche Energy (Note 3)	$E_{AR}$	0.05	
ESD susceptibility (Note 5)	$V_{ESD}$	1000	V
Power Dissipation	$P_D$	$T_C=25^{\circ}\text{C}$ (Note 1)	25
		$T_C=100^{\circ}\text{C}$ (Note 1)	10
	$P_{DSM}$	$T_A=25^{\circ}\text{C}$ (Note 2)	2
		$T_A=70^{\circ}\text{C}$ (Note 2)	1.3
Operating Junction and Storage Temperature	$T_j, T_{stg}$	-55~+150	$^{\circ}\text{C}$

\*Drain current limited by maximum junction temperature

**Thermal Data**

Parameter	Symbol	Value	Unit
Thermal Resistance, Junction-to-case, max	$R_{\theta JC}$	5	$^{\circ}\text{C}/\text{W}$
Thermal Resistance, Junction-to-ambient, max (Note 4)	$R_{\theta JA}$	62.5	

- Note : 1.The power dissipation  $P_D$  is based on  $T_{J(MAX)}=150^{\circ}\text{C}$ , using junction-to-case thermal resistance, and is more useful in setting the upper dissipation limit for cases where additional heatsinking is used.
- 2.The value of  $R_{\theta JA}$  is measured with the device mounted on 1 in<sup>2</sup>FR-4 board with 2 oz. copper, in a still air environment with  $T_A=25^{\circ}\text{C}$ . The value in any given application depends on the user's specific board design. The power dissipation  $P_{DSM}$  is based on  $R_{\theta JA}$  and the maximum allowed junction temperature of  $150^{\circ}\text{C}$ .
3. Ratings are based on low frequency and low duty cycles to keep initial  $T_J=25^{\circ}\text{C}$ .
4. When mounted on 1 in<sup>2</sup>copper pad of FR-4 board ;  $125^{\circ}\text{C}/\text{W}$  when mounted on minimum copper pad.
5. Human body model,  $1.5\text{k}\Omega$  in series with  $100\text{pF}$

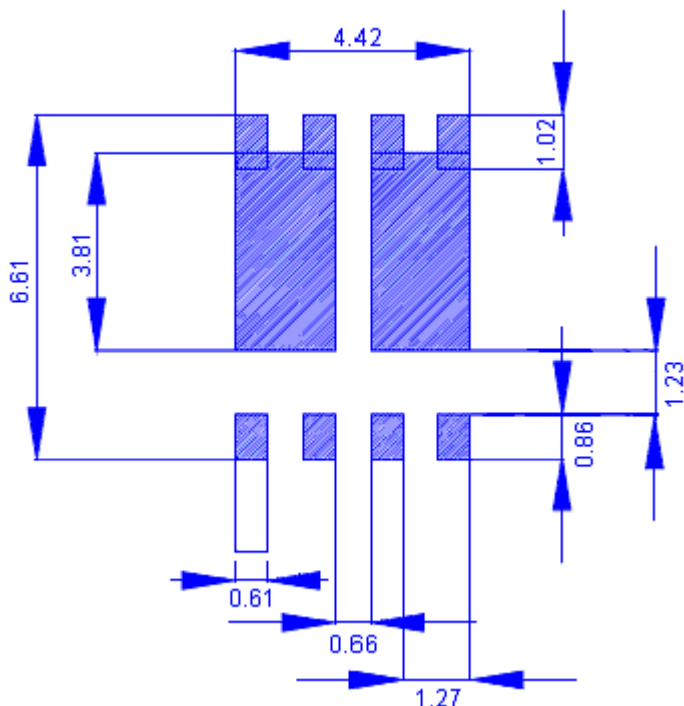
**Characteristics ( $T_J=25^{\circ}\text{C}$ , unless otherwise specified)**

Symbol	Min.	Typ.	Max.	Unit	Test Conditions
<b>Static</b>					
$BV_{DSS}$	60	-	-	V	$V_{GS}=0\text{V}$ , $I_D=250\mu\text{A}$
$\Delta BV_{DSS}/\Delta T_j$	-	0.04	-	$\text{V}/^{\circ}\text{C}$	Reference to $25^{\circ}\text{C}$ , $I_D=250\mu\text{A}$
$V_{GS(th)}$	1.0	-	2.5	V	$V_{DS} = V_{GS}$ , $I_D=250\mu\text{A}$
* $G_{FS}$	-	1.9	-	S	$V_{DS} = 5\text{V}$ , $I_D=1\text{A}$
$I_{GSS}$	-	-	$\pm 10$	$\mu\text{A}$	$V_{GS}=\pm 16\text{V}$ , $V_{DS}=0\text{V}$
$I_{DSS}$	-	-	1		$V_{DS} = 48\text{V}$ , $V_{GS} = 0\text{V}$
	-	-	25		$V_{DS} = 48\text{V}$ , $V_{GS} = 0\text{V}$ , $T_j=85^{\circ}\text{C}$

*R <sub>DS(ON)</sub>	-	82	135	mΩ	V <sub>GS</sub> =10V, I <sub>D</sub> =2.2A
	-	116	160		V <sub>GS</sub> =4.5V, I <sub>D</sub> =1.3A
	-	183	500		V <sub>GS</sub> =3.3V, I <sub>D</sub> =1A
<b>Dynamic</b>					
*Q <sub>g</sub> (V <sub>GS</sub> =10V)	-	3.2	-	nC	V <sub>DS</sub> =30V, I <sub>D</sub> =2.2A, V <sub>GS</sub> =10V
*Q <sub>g</sub> (V <sub>GS</sub> =4.5V)	-	1.35	-		
*Q <sub>gs</sub>	-	0.9	-		
*Q <sub>gd</sub>	-	0.2	-		
*t <sub>d(ON)</sub>	-	5.6	-	ns	V <sub>DS</sub> =30V, I <sub>D</sub> =2.2A, V <sub>GS</sub> =10V, R <sub>G</sub> =1Ω
*t <sub>r</sub>	-	1.4	-		
*t <sub>d(OFF)</sub>	-	12.8	-		
*t <sub>f</sub>	-	1	-		
C <sub>iss</sub>	-	120	-	pF	V <sub>GS</sub> =0V, V <sub>DS</sub> =30V, f=1MHz
C <sub>oss</sub>	-	30	-		
C <sub>rss</sub>	-	13	-		
R <sub>g</sub>	-	9.9	-	Ω	f=1MHz
<b>Source-Drain Diode</b>					
*I <sub>S</sub>	-	-	11.3	A	
*I <sub>SM</sub>	-	-	30		
*V <sub>SD</sub>	-	0.79	1	V	I <sub>S</sub> =0.5A, V <sub>GS</sub> =0V
*t <sub>rr</sub>	-	7.5	-	ns	V <sub>GS</sub> =0V, I <sub>F</sub> =2.2A, dI <sub>F</sub> /dt=100A/μs
*Q <sub>rr</sub>	-	2.9	-	nC	

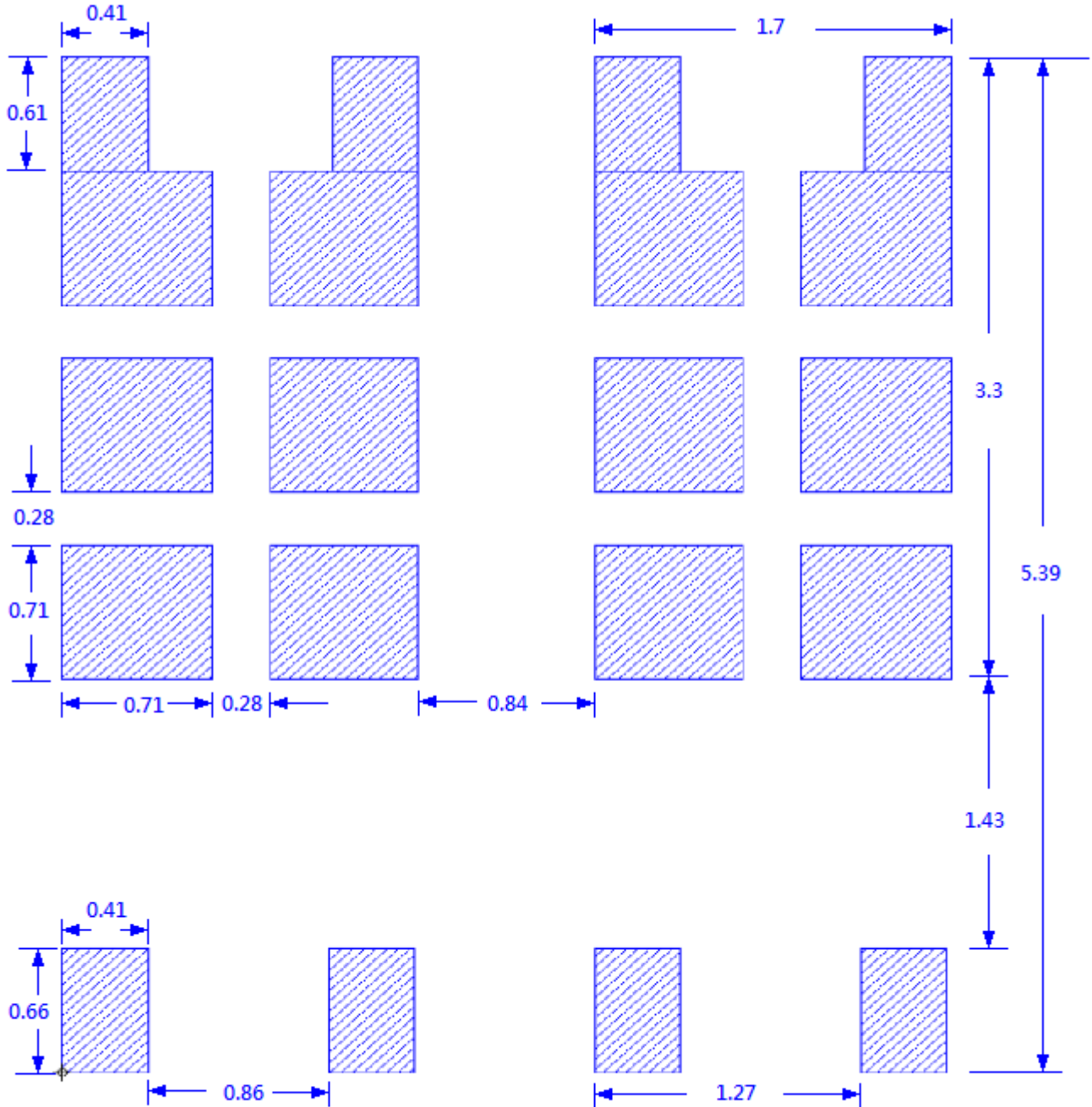
\*Pulse Test : Pulse Width ≤300μs, Duty Cycle≤2%

**Recommended Soldering Footprint**



unit : mm

**Recommended Stencil Design**

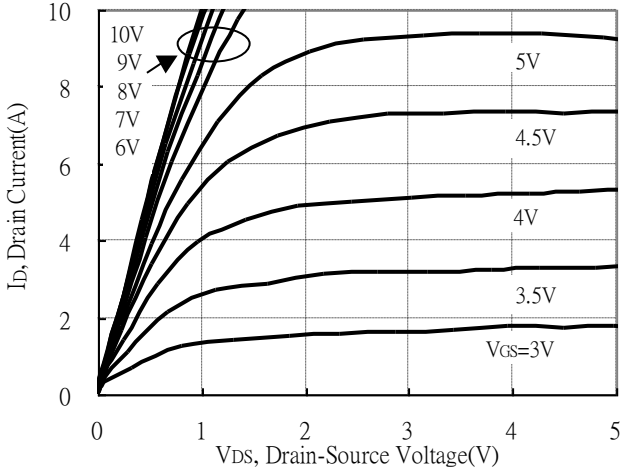


unit : mm

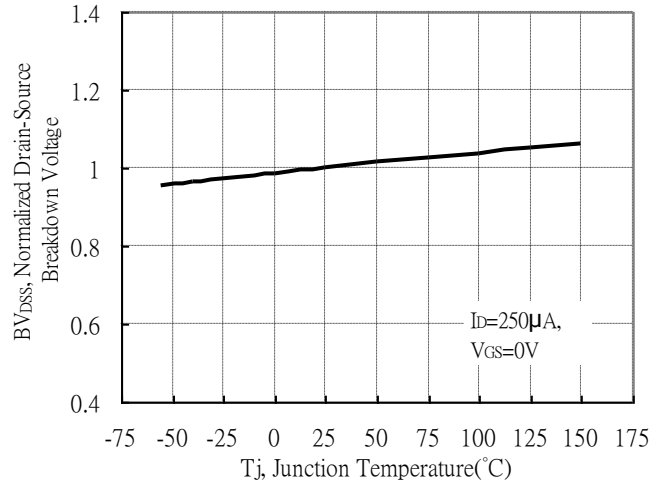
- Note :**
1. Stencil thickness 5 mil (0.127mm)
  2. May need to be adjusted to specific requirements.

**Typical Characteristics**

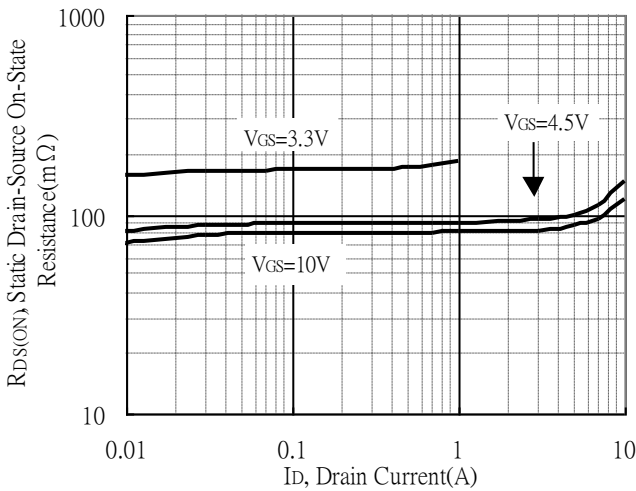
Typical Output Characteristics



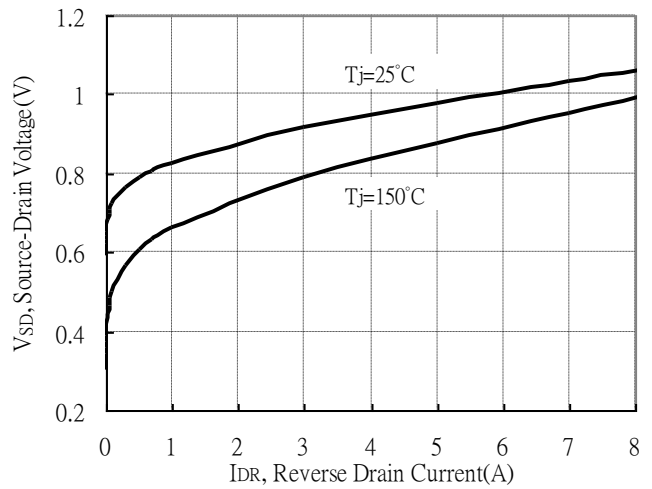
Breakdown Voltage vs Ambient Temperature



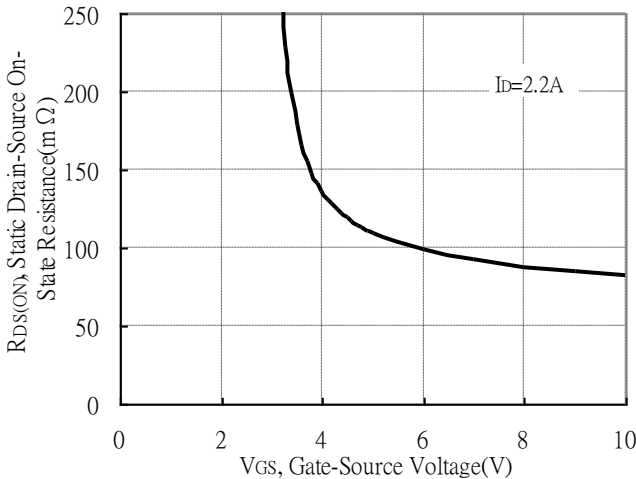
Static Drain-Source On-State resistance vs Drain Current



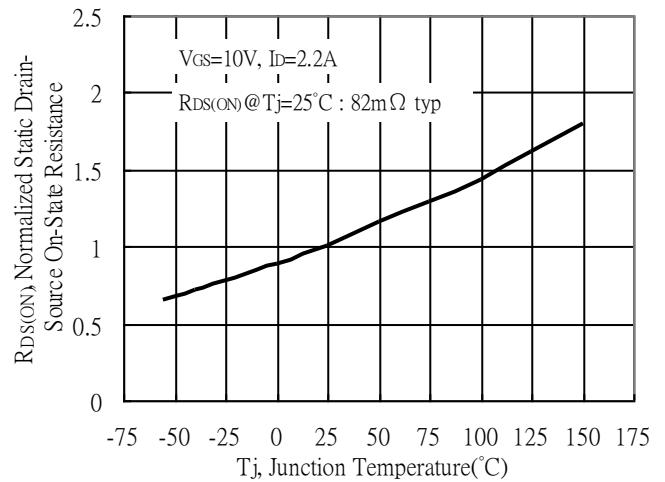
Reverse Drain Current vs Source-Drain Voltage



Static Drain-Source On-State Resistance vs Gate-Source Voltage

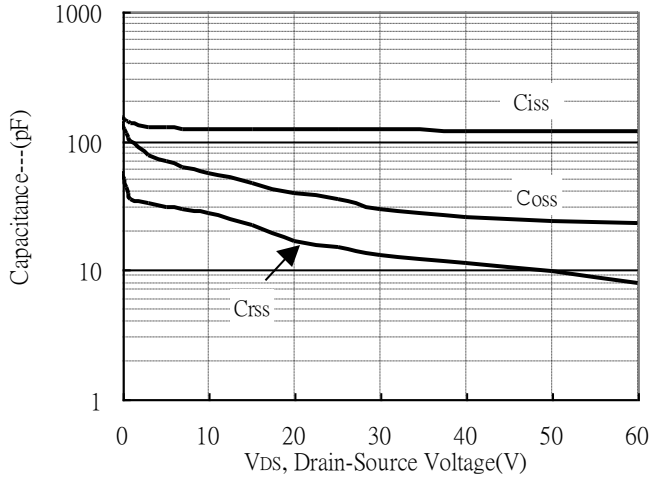


Drain-Source On-State Resistance vs Junction Temperature

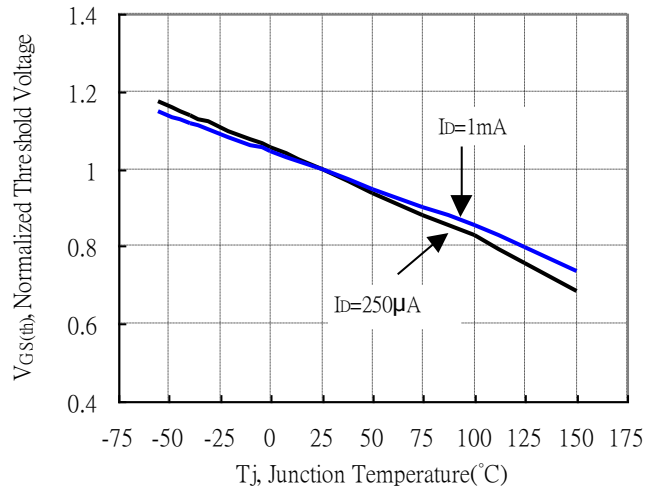


## Typical Characteristics(Cont.)

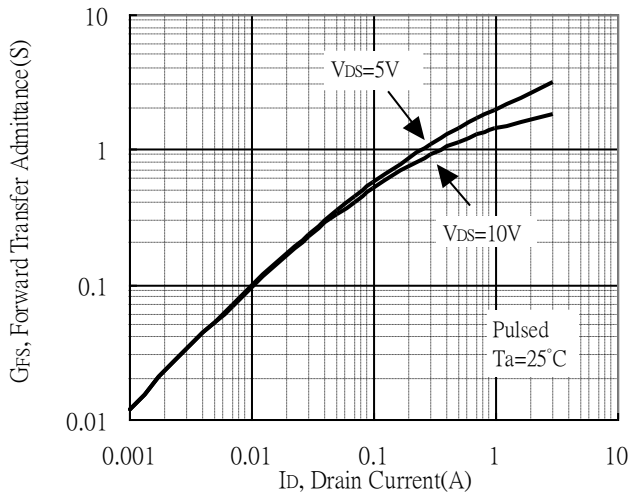
Capacitance vs Drain-to-Source Voltage



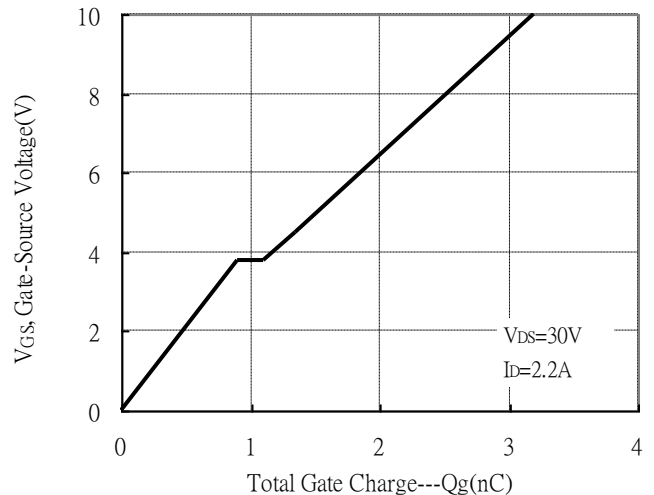
Normalized Threshold Voltage vs Junction Temperature



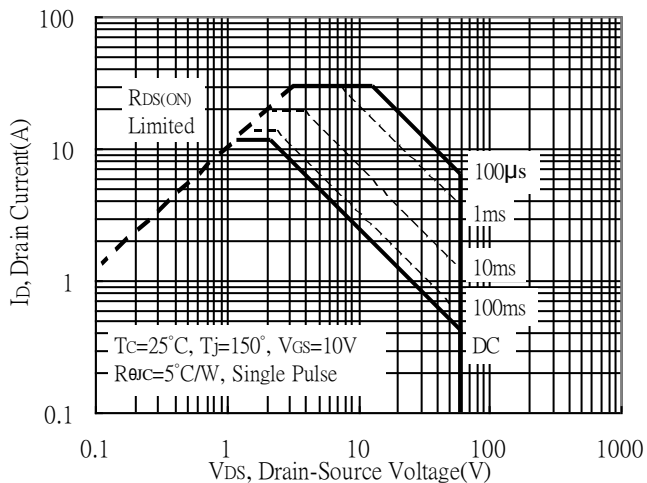
Forward Transfer Admittance vs Drain Current



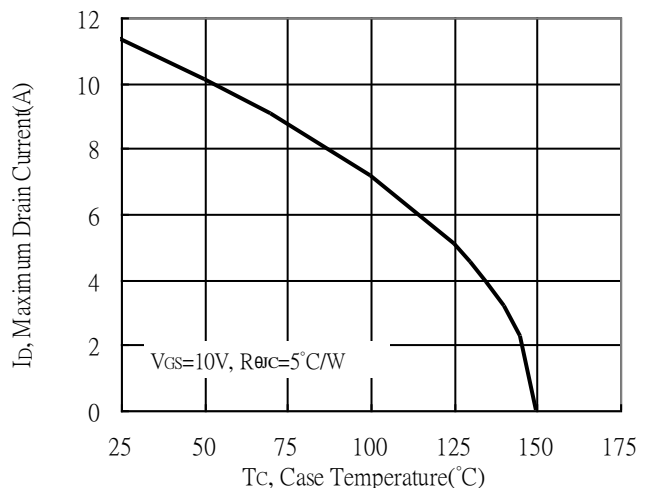
Gate Charge Characteristics



Maximum Safe Operating Area

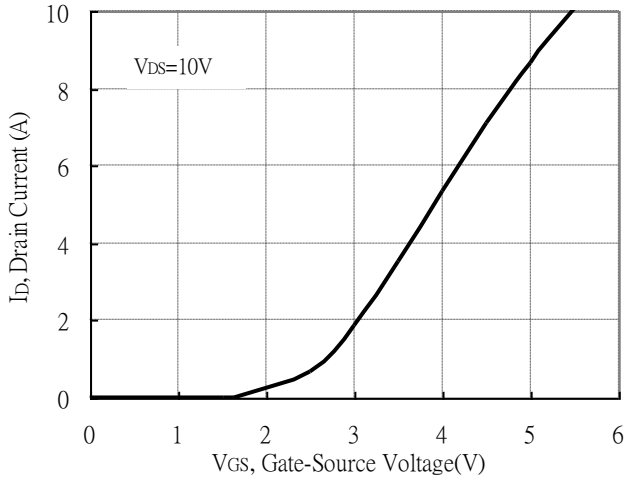


Maximum Drain Current vs Case Temperature

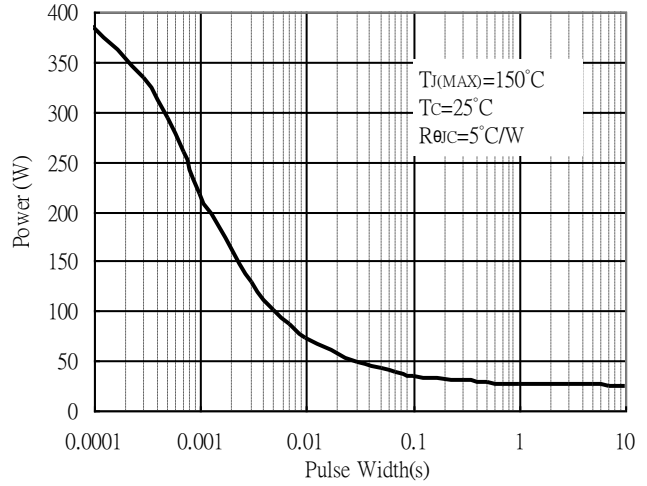


**Typical Characteristics(Cont.)**

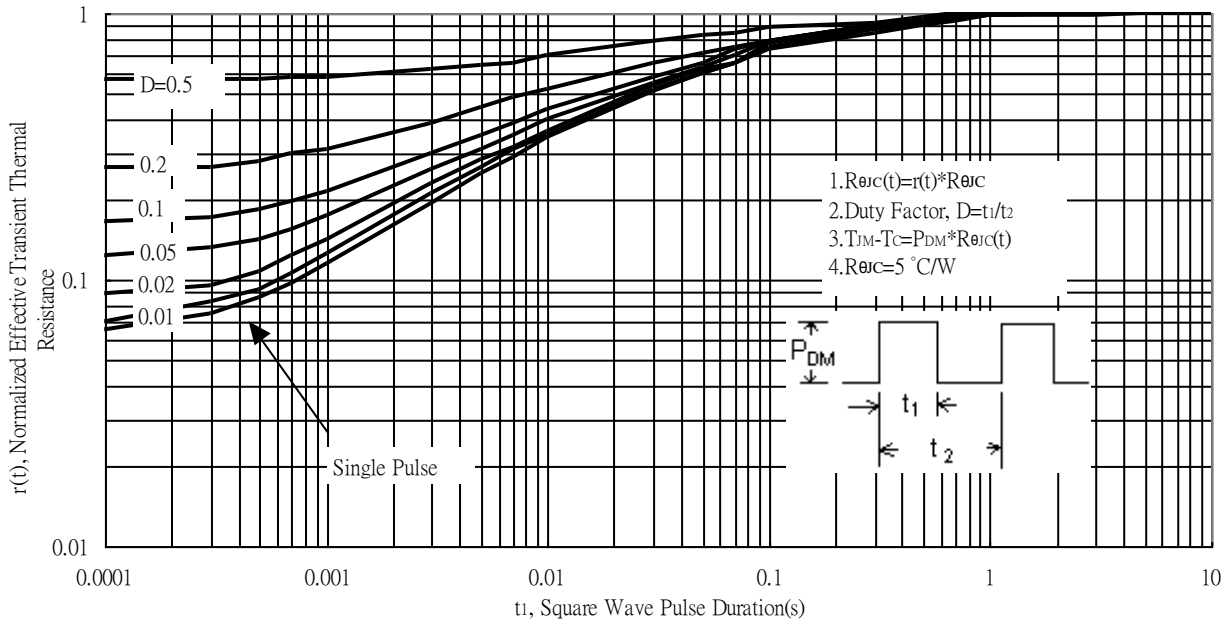
Typical Transfer Characteristics



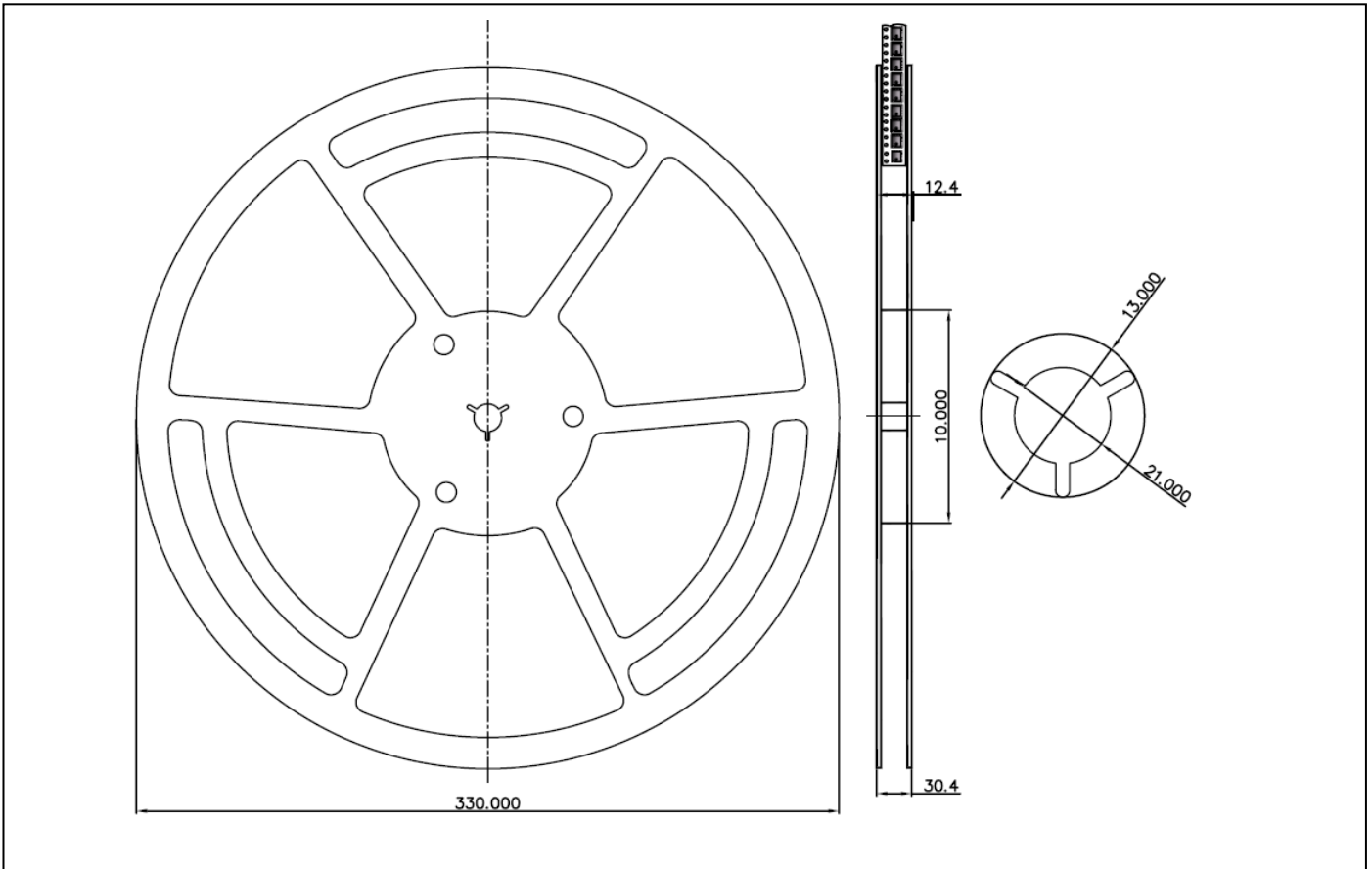
Single Pulse Maximum Power Dissipation



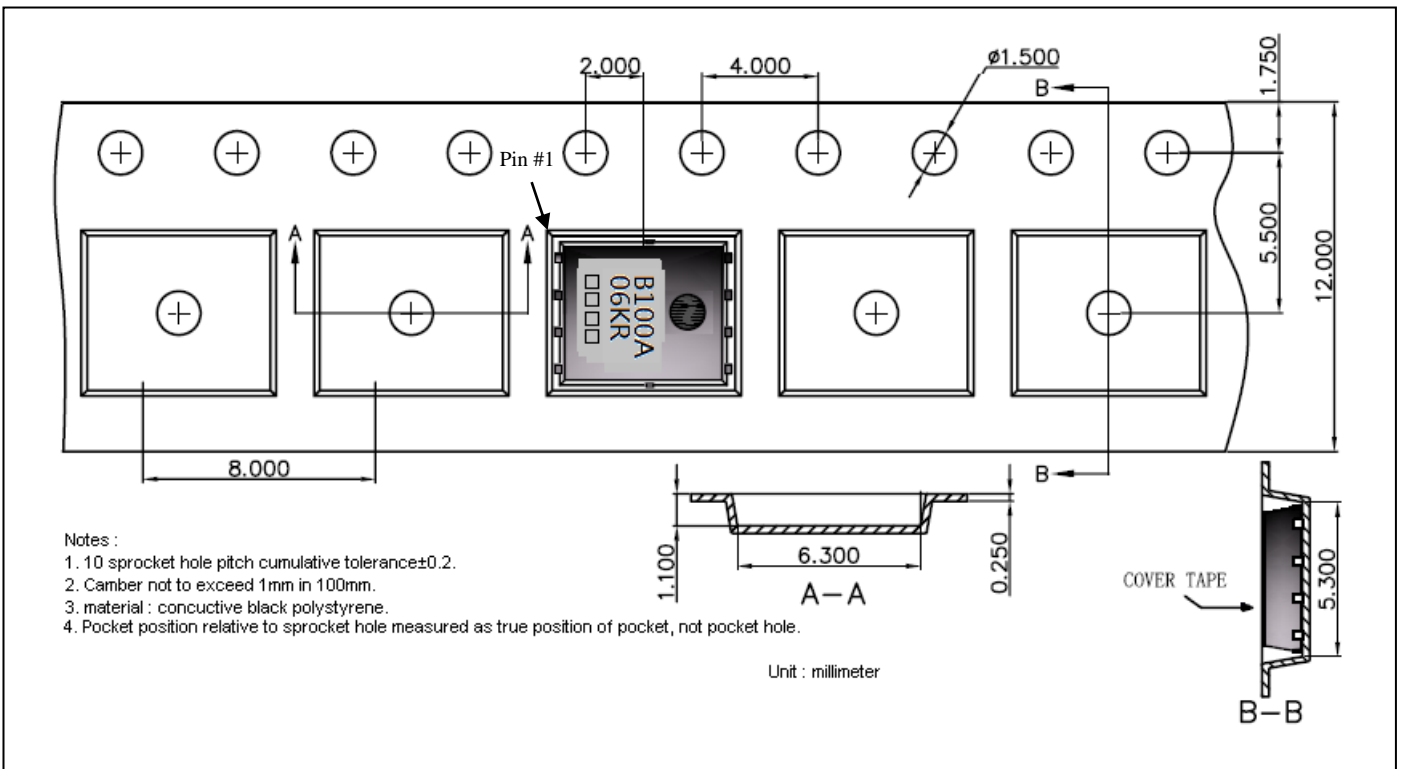
Transient Thermal Response Curves



**Reel Dimension**



**Carrier Tape Dimension**

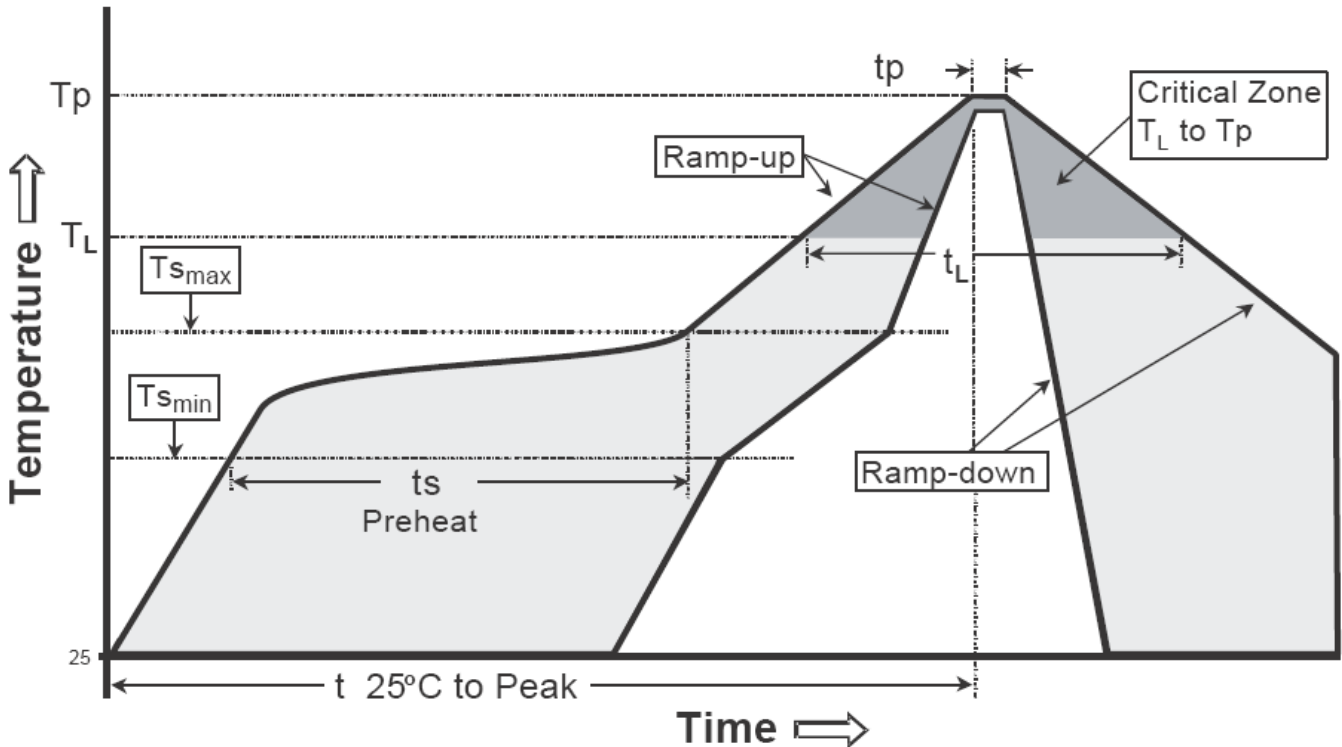




**Recommended wave soldering condition**

Product	Peak Temperature	Soldering Time
Pb-free devices	260 +0/-5 °C	5 +1/-1 seconds

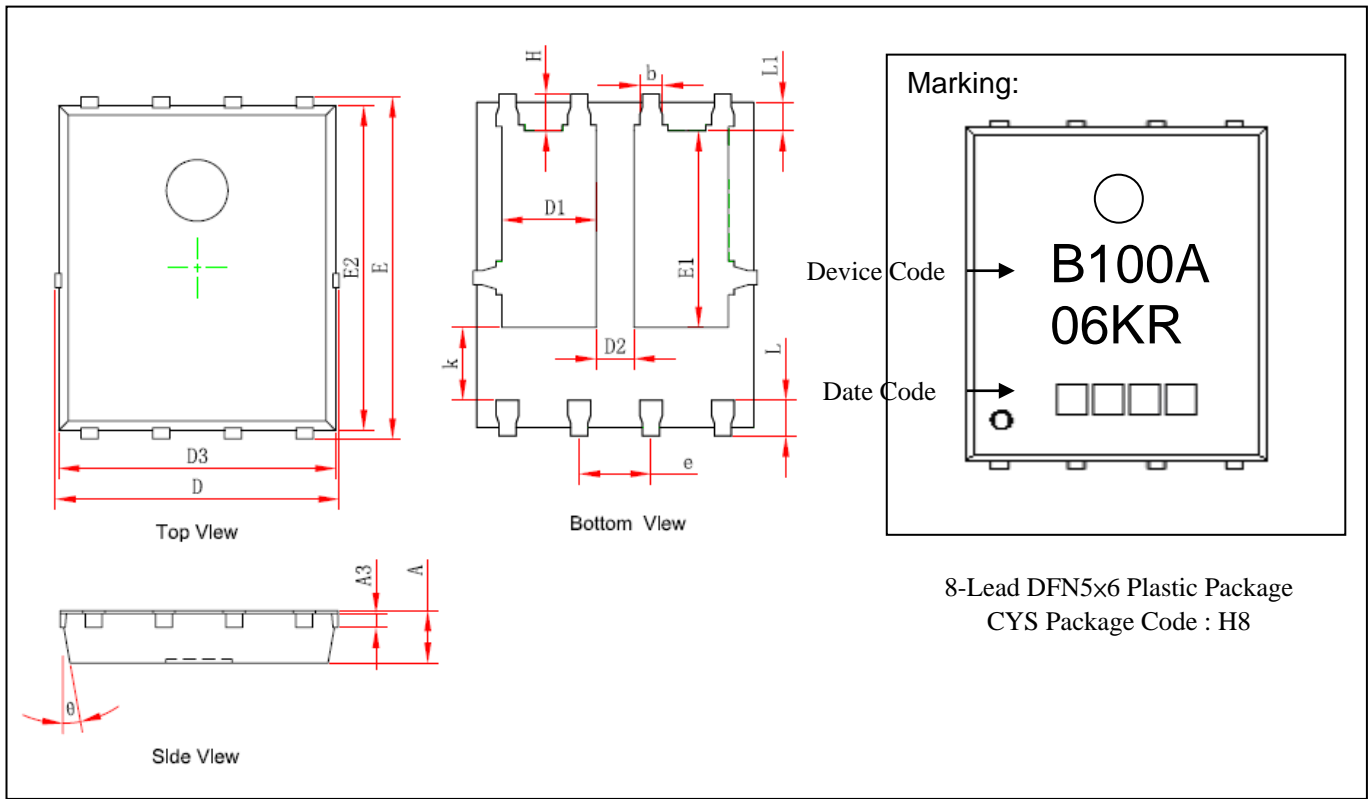
**Recommended temperature profile for IR reflow**



Profile feature	Sn-Pb eutectic Assembly	Pb-free Assembly
Average ramp-up rate (T <sub>smax</sub> to T <sub>p</sub> )	3°C/second max.	3°C/second max.
Preheat		
-Temperature Min(T <sub>s min</sub> )	100°C	150°C
-Temperature Max(T <sub>s max</sub> )	150°C	200°C
-Time(t <sub>s min</sub> to t <sub>s max</sub> )	60-120 seconds	60-180 seconds
Time maintained above:		
-Temperature (T <sub>L</sub> )	183°C	217°C
- Time (t <sub>L</sub> )	60-150 seconds	60-150 seconds
Peak Temperature(T <sub>p</sub> )	240 +0/-5 °C	260 +0/-5 °C
Time within 5°C of actual peak temperature(tp)	10-30 seconds	20-40 seconds
Ramp down rate	6°C/second max.	6°C/second max.
Time 25 °C to peak temperature	6 minutes max.	8 minutes max.

Note :1. All temperatures refer to topside of the package, measured on the package body surface.  
 2.For devices mounted on FR-4 PCB of 1.6mm or equivalent grade PCB. If other grade PCB is used, care should be taken to match the coefficients of thermal expansion between components and PCB. If they are not matched well, the solder joints may crack or the bodies of the parts may crack or shatter as the assembly cools.

**DFN5x6 Dimension**



DIM	Millimeters		Inches		DIM	Millimeters		Inches	
	Min.	Max.	Min.	Max.		Min.	Max.	Min.	Max.
A	0.900	1.000	0.035	0.039	E2	5.674	5.826	0.223	0.229
A3	0.254	REF	0.010	REF	k	1.190	1.390	0.047	0.055
D	4.944	5.096	0.195	0.201	b	0.350	0.450	0.014	0.018
E	5.974	6.126	0.235	0.241	e	1.270 TYP		0.050 TYP	
D1	1.470	1.870	0.058	0.074	L	0.559	0.711	0.022	0.028
D2	0.470	0.870	0.019	0.034	L1	0.424	0.576	0.017	0.023
E1	3.375	3.575	0.133	0.141	H	0.574	0.726	0.023	0.029
D3	4.824	4.976	0.190	0.196	θ	10°	12°	10°	12°

Notes: 1.Controlling dimension: millimeters.  
 2.Maximum lead thickness includes lead finish thickness, and minimum lead thickness is the minimum thickness of base material.  
 3.If there is any question with packing specification or packing method, please contact your local CYStek sales office.

**Material:**

- Lead: Pure tin plated.
- Mold Compound: Epoxy resin family, flammability solid burning class: UL94V-0.

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